Comments:

# SPECIFICATIONS

Customer					
Product Name	•	Multi-layer Chip Ferrite Bead			
Sunlord Part I	Number	MZPA2012D300-8R5TF			
Customer Par	t Number				
New Release 【This SPEC is to 【ROHS Complian	tal 10 pages.		SPEC N	o.: <mark>MZPA01</mark>	240000
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# 【Version change history】

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
01	/	New release	1	Chunlei Dai

## Caution

All products listed in this specification are developed, designed and intended for use in general electronics equipment. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below. Please contact us for more details if you intend to use our products in the following applications.

- 1. Aircraft equipment
- 2. Aerospace equipment
- 3. Undersea equipment
- 4. Nuclear control equipment
- 5. Military equipment
- 6. Power plant equipment
- 7. Medical equipment
- 8. Transportation equipment (automobiles, trains, ships, etc.)
- 9. Traffic signal equipment
- 10. Disaster prevention / crime prevention equipment
- 11. Applications of similar complexity or with reliability requirements comparable to the applications listed in the above

#### Scope

This specification applies to MZPA2012D300-8R5TF of multi-layer ferrite chip bead.

## 2. Product Description and Identification (Part Number)

1) Description:

MZPA2012D300-8R5TF of Multi-layer ferrite chip beads.

2) Product Identification (Part Number)

<u>MZPA</u>	<u>2012</u>	<u>D</u>	<u>300</u>	<u>-8R5</u>	<u>T</u>	<u>F</u>
1	2	3	4	(5)	6	7

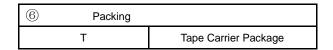
1	Туре
MZPA	High Current Power Bead

2	External Dimensions (L X W) (mm)		
2012 [0805]		2.0X 1.25	

3	Material Code	
	D	

4 Nominal	Nominal Impedance	
Example	Nominal Value	
300	30Ω	

⑤ Rate Current	
8R5	8.5A



7	HSF Products
	Hazardous Substance Free Products

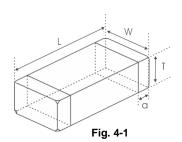
#### 3. Electrical Characteristics

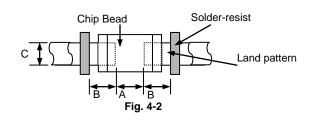
Please refer to Appendix A (Page 10).

- 1) Operating and storage temperature range (individual chip without packing): -55 $^{\circ}$ C ~+125 $^{\circ}$ C.
- 1) Storage temperature range (packaging conditions): -10°C~+40°C and RH 70% (Max.)

# 4. Shape and Dimensions

- 1) Dimensions and recommended PCB pattern for reflow soldering: See Fig.4-1, Fig.4-2 and Table 4-1.
- 2) Structure: See Fig. 4-3 and Fig. 4-4.

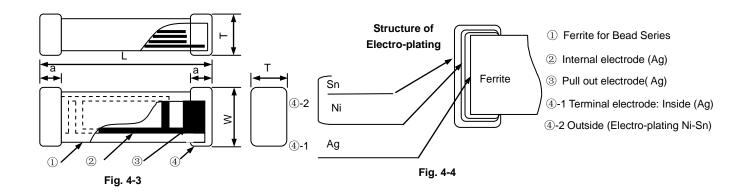




[Table 4-1]

Unit: mm [inch]

Туре	L	W	T	а	Α	В	С
2012 [0805]	2.0±0.2 [.079 ±.008]	1.25±0.2 [.049±.008)]	0.85±0.2 [.033±.008]	0.5±0.3 [.020±.012]	0.80~1.20	0.80~1.20	0.90~1.60



Material Information: See Table 4-2.

[Table 4-2]

Code	Part Name	Material Name
1	Ferrite Body	Ferrite Powder
2	Inner Coils	Silver Paste
3	Pull-out Electrode (Ag)	Silver Paste
<b>4</b> -1	Terminal Electrode: Inside Ag	Termination Silver Composition
<b>4</b> -2	Electro-Plating: Ni/Sn plating	Plating Chemicals

## **Test and Measurement Procedures**

#### **5.1 Test Conditions**

Unless otherwise specified, the standard atmospheric conditions for measurement/test as:

Ambient Temperature: 20±15℃ b. Relative Humidity: 65±20%

Air Pressure: 86kPa to 106kPa C.

If any doubt on the results, measurements/tests should be made within the following limits:

Ambient Temperature: 20±2°C Relative Humidity: 65±5% b. c. Air Pressure: 86kPa to 106kPa

#### 5.2 Visual Examination

a. Inspection Equipment: 20x magnifier

#### 5.3 Electrical Test

#### 5.3.1 DC Resistance (DCR)

- a. Refer to Appendix A.
- Test equipment (Analyzer): DCR>50 mΩ measured with HP4338B;DCR≤50 mΩ measured with RM3545 h.

## 5.3.2 Impedance (Z)

- Refer to Appendix A. a.
- Test equipment: High Accuracy RF Impedance /Material Analyzer-E4991A or equivalent.

Test fixture: HP16192A Test signal: -20dBm or 50mV

Test frequency refers to Appendix A.

## 5.3.3 Rated Current

- a. Refer to Appendix A.
- b. Test equipment (see Fig. 5.3.3-1): Electric Power, Electric current meter, Thermometer.
- Measurement method (see Fig. 5.3.3-1):
  - 1. Set test current to be 0mA.
  - 2. Measure initial temperature of chip surface.
  - 3. Gradually increase voltage and measure chip temperature for corresponding current.
- d. Definition of Rated Current (Ir): Ir is direct electric current as chip surface temperature rose just 40°C. against chip initial surface temperature(Ta). (see Fig. 5.3.3-2):

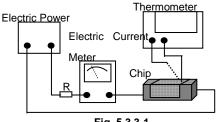


Fig. 5.3.3-1

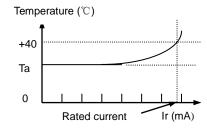


Fig. 5.3.3-2

e. When operating temperatures exceeding +85 °C, derating of current is necessary for chip ferrite beads for which rated current is 1000mA and over. Please apply the derating curve shown in chart Fig. 5.3.3-3 according to the operating temperature.

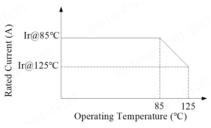


Fig. 5.3.3-3

# 5.4 Reliability Test

Items	Requirements	Test Methods and Remarks
5.4.1 Terminal Strength	No removal or split of the termination or other defects shall occur.  Chip  Mounting Pad  Glass Epoxy Board  Fig.5.4.1-1	<ol> <li>Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.1-1) using leadfree solder. Then apply a force in the direction of the arrow.</li> <li>2N force for 0603 series ,5N force for 1005 and 1608 series, 10N force for 2012 ,3216 and 4516 series.</li> <li>Keep time: 10±1s.</li> <li>Speed:1.0mm/s.</li> </ol>
5.4.2 Resistance to Flexure	No visible mechanical damage.    Type	<ul> <li>Solder the bead to the test jig (glass epoxy board shown in Fig. 5.4.2-1) Using a leadfree solder. Then apply a force in the direction shown Fig. 5.4.2-2.</li> <li>Flexure: 2mm.</li> <li>Pressurizing Speed: 0.5mm/sec.</li> <li>Keep time: 30 sec. 20</li> <li>R230</li> <li>Flexure</li> <li>Flexure</li> <li>Flexure</li> <li>Flexure</li> </ul>
5.4.3 Vibration	No visible mechanical damage.     Impedance change: Within ±30%.  Cu pad Solder mask  Glass Epoxy Board  Fig. 5.4.3-1	<ol> <li>Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.3-1) using leadfree solder.</li> <li>The bead shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz.</li> <li>The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3mutually perpendicular directions (total of 6 hours).</li> </ol>
5.4.4 Dropping	<ol> <li>No visible mechanical damage.</li> <li>Impedance change: Within ±30%.</li> </ol>	Drop chip bead 10 times on a concrete floor from a height of 100 cm.
5.4.5 Solderability	<ol> <li>No visible mechanical damage.</li> <li>Wetting shall exceed 95% coverage</li> </ol>	<ol> <li>Solder temperature: 240±2℃.</li> <li>Duration: 3 sec.</li> <li>Solder: Sn/3.0Ag/0.5Cu.</li> <li>Flux: 25% Resin and 75% ethanol in weight.</li> </ol>
5.4.6 Resistance to Soldering Heat	<ol> <li>No visible mechanical damage.</li> <li>Wetting shall exceed 95% coverage</li> <li>Impedance change: within ±30%.</li> </ol>	<ol> <li>Solder temperature: 260±3°C</li> <li>Duration: 5 sec.</li> <li>Solder: Sn/3.0Ag/0.5Cu.</li> <li>Flux: 25% Resin and 75% ethanol in weight.</li> <li>The chip shall be stabilized at normal condition for 1~2 hours before measuring.</li> </ol>

5.4.7 Thermal Shock	① No mechanical damage. ② Impedance change: Within ±30%  125°C 30 min.  Ambient 30 min.  Temperature 30 min.  Fig.5.4.7-1 20sec. (max.)	<ol> <li>Temperature, Time: (See Fig. 5.4.7-1)         -55°C for 30±3 min→125°C for 30±3min</li> <li>Transforming interval: Max. 20 sec.</li> <li>Tested cycle: 100 cycles.</li> <li>The chip shall be stabilized at normal condition for 1~2 hours before measuring.</li> </ol>
5.4.8 Resistance to Low Temperature	No mechanical damage.     Impedance change: Within ±30%	<ol> <li>Temperature: -55±2°C</li> <li>Duration: 1000<sup>+24</sup> hours.</li> <li>The chip shall be stabilized at normal condition for 1~2 hours before measuring.</li> </ol>
5.4.9 Resistance to High Temperature	No mechanical damage.     Impedance change: Within ±30%	<ol> <li>Temperature: 125±2℃.</li> <li>Duration: 1000<sup>+24</sup> hours.</li> <li>The chip shall be stabilized at normal condition for 1~2 hours before measuring.</li> </ol>
5.4.10 Damp Heat (Steady States)	No visible mechanical damage.     Impedance change: Within ±30%	<ol> <li>Temperature: 85±2℃.</li> <li>Humidity: 85% RH.</li> <li>Duration: 1000+24 hours.</li> <li>The chip shall be stabilized at normal condition for 1~2 hours before measuring.</li> </ol>
5.4.11 Loading Under Damp Heat	No visible mechanical damage.     Impedance change: Within ±30%	<ol> <li>Temperature: 85±2℃.</li> <li>Humidity: 85% RH.</li> <li>Duration: 1000<sup>+24</sup> hours.</li> <li>Applied current: Rated current.</li> <li>The chip shall be stabilized at normal condition for 1~2 hours before measuring.</li> </ol>
5.4.12 Loading at High Temperature (Life Test)	No visible mechanical damage.     Impedance change: Within ±30%	<ol> <li>Temperature: 85±2°C</li> <li>Duration: 1000<sup>+24</sup> hours.</li> <li>Applied current: Rated current.</li> <li>The chip shall be stabilized at normal condition for 1~2 hours before measuring.</li> </ol>

# 5. Packaging, Storage

# 6.1 Packaging

Tape Carrier Packaging:

Packaging code: T

- a. Tape carrier packaging are specified in attached figure Fig. 6.1-1~3
- b. Tape carrier packaging quantity please see the following table:

Туре	2012[0805]
T(mm)	0.85±0.2
Tape	Paper Tape
Quantity	3K

## (1) Taping Drawings (Unit: mm)

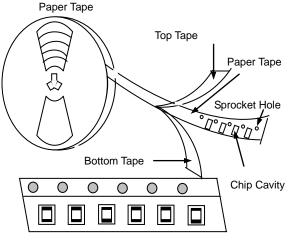
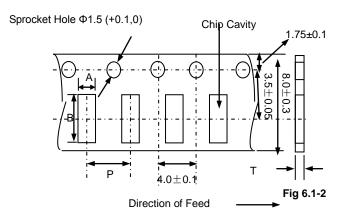


Fig. 6.1-1

Remark: The sprocket holes are to the right as the tape is pulled toward the user.

## (2) Taping Dimensions (Unit: mm)



Paper Tape and Reel

Туре	Α	В	Р	T max	H
2012[0805]	1.5±0.2	2.3±0.2	4.0±0.1	1.1	10

# (3) Reel Dimensions (Unit: mm)

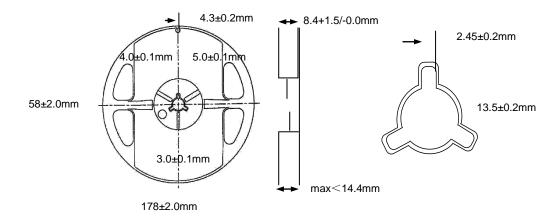


Fig. 6.1-3

#### 6.2 Storage

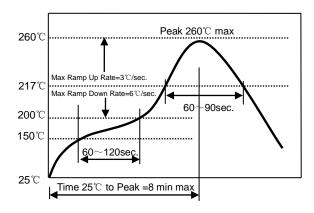
- The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity.
   Package must be stored at 40°C or less and 70% RH or less.
- b. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCl, sulfurous gas of H<sub>2</sub>S).
- c. Packaging material may be deformed if package are stored where they are exposed to heat of direct sunlight.
- d. Minimum packages, such as polyvinyl heat-seal packages shall not be opened until they are used. If opened, use the reels as soon as possible.
- e. Solderability specified in **Clause 5.4.5** shall be guaranteed for 12months from the date of delivery on condition that they are stored at the environment specified in **Clause 3**. For those parts, which passed more than 12 months shall be checked solder-ability before use

# 7. Recommended Soldering Technologies

#### 7.1 Reflowing Profile:

- △ Preheat condition: 150 ~200°C/60~120sec.
- △ Allowed time above 217°C: 60~90sec.
- △ Max temp: 260°C
- $\triangle$  Max time at max temp: 10sec.  $\triangle$  Solder paste: Sn/3.0Ag/0.5Cu
- $\triangle$  Allowed Reflow time: 2x max

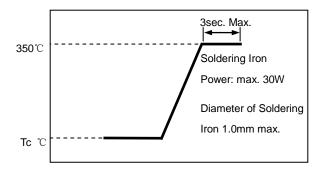
[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]



#### 7.2 Iron Soldering Profile.

- △ Iron soldering power: Max.30W
- $\triangle$  Pre-heating: 150  $^{\circ}$ C / 60sec.
- $\triangle$  Soldering Tip temperature: 350  $^{\circ}\text{CMax}.$
- △ Soldering time: 3sec Max.
   △ Solder paste: Sn/3.0Ag/0.5Cu
   △ Max.1 times for iron soldering

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]



# **Appendix A: Electrical Characteristics**

Pa		Impedanc Z Test Freq. e (Ω) (MHz)	Z Test Freq.	DCR (mΩ) Max.		Ir (mA) Max*		Thickness
	Part Number		Initial Value	Value After Testing	at 85℃	at 125℃	(mm)[inch]	
	MZPA2012D300-8R5TF	30±10	100	4	5	8500	6000	0.85±0.2 [.033±.008]

# Impedance Frequency Characteristics

